Search Notes



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10/601,632 Examiner

Hetul Patel

Applicant(s)/Patent under Reexamination

OKUYAMA ET AL.

Art Unit

2186

SEARCHED					
Class	Subclass	Date	Examiner		
711	163	1/26/2006	нвр		
	164	1/26/2006	НВР		
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INTERFERENCE SEARCHED					
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711	163	1/26/2006	НВР		
	164	1/26/2006	нвр		

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